

IEC QUALITY ASSESSMENT SYSTEM (IECQ)

covering Electronic Components, Assemblies, Related Materials and Processes

For rules and details of the IECQ visit www.iecq.org

Schedule of Scope to Certificate of Approval Independent Testing Laboratory

IECQ Certificate No.: IECQ-L ULTW 19.0007
CB Certificate No.: 50600337 ITL

Schedule Number: IECQ-L ULTW 19.0007-S Rev No.: 4 Revision Date: 2022/11/22 Page 1 of 2

Appendix-1 (50600337 ITL)

Schedule of Scope to Certificate of Approval

Test Items	Standard/Method
TCT - Temperature Cycling 温度循环试验	JESD22-A104 / AEC-Q100 Group A4
HTSL- High Temperature Storage Life 高温存储试验	JESD22-A103 / AEC-Q100 Group A3
LTSL- Low Temperature Storage Life 低温存储试验	JESD22-A119
THB - Temperature-Humidity Bias Life Test 高温高湿偏压试验	JESD22-A101 / AEC-Q100 Group A2
PCT- Accelerated Moisture Resistance - Unbiased Autoclave 高温水蒸汽压力试验	JESD22-A102 / AEC-Q100 Group A3
HAST-Highly Accelerated Temperature and Humidity Stress Test 高加速应力试验 UHAST - Accelerated Moisture Resistance - Unbiased HAST 无偏压高加速应力试验	JESD22-A110 / JESD22-A118 / AEC- Q100 Group A2/A3
HTOL- High Temperature Operating Life Test 高温寿命试验	JESD22-A108 / AEC Q100 Group B1
LTOL- Low Temperature Operating Life Test 低温寿命试验	JESD22-A108
BLT- Bias Life test 高温偏压试验	JESD22-A108
ELFR- Early Life Failure Rate 早夭期试验	JESD22-A108 / AEC Q100-008
Pre-condition- Preconditioning of Nonhermetic Surface Mount Devices Prior to Reliability Testing 预处理试验	JESD22-A113 / AEC-Q100 Group A1
PTC- Power and Temperature Cycling 电源温度循环试验	JESD22-A105 / AEC-Q100 Group A5
HTFB- High temperature forward bias test 高温顺向偏压测试	JESD22-A108

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HTRB- High temperature reverse bias test 高温逆向偏压测试	JESD22-A108
HTGB- High temperature gate bias test 高温闸极偏压测试	JESD22-A108

Technical Reviewer of DQS:

Date: 11/22/2022



